

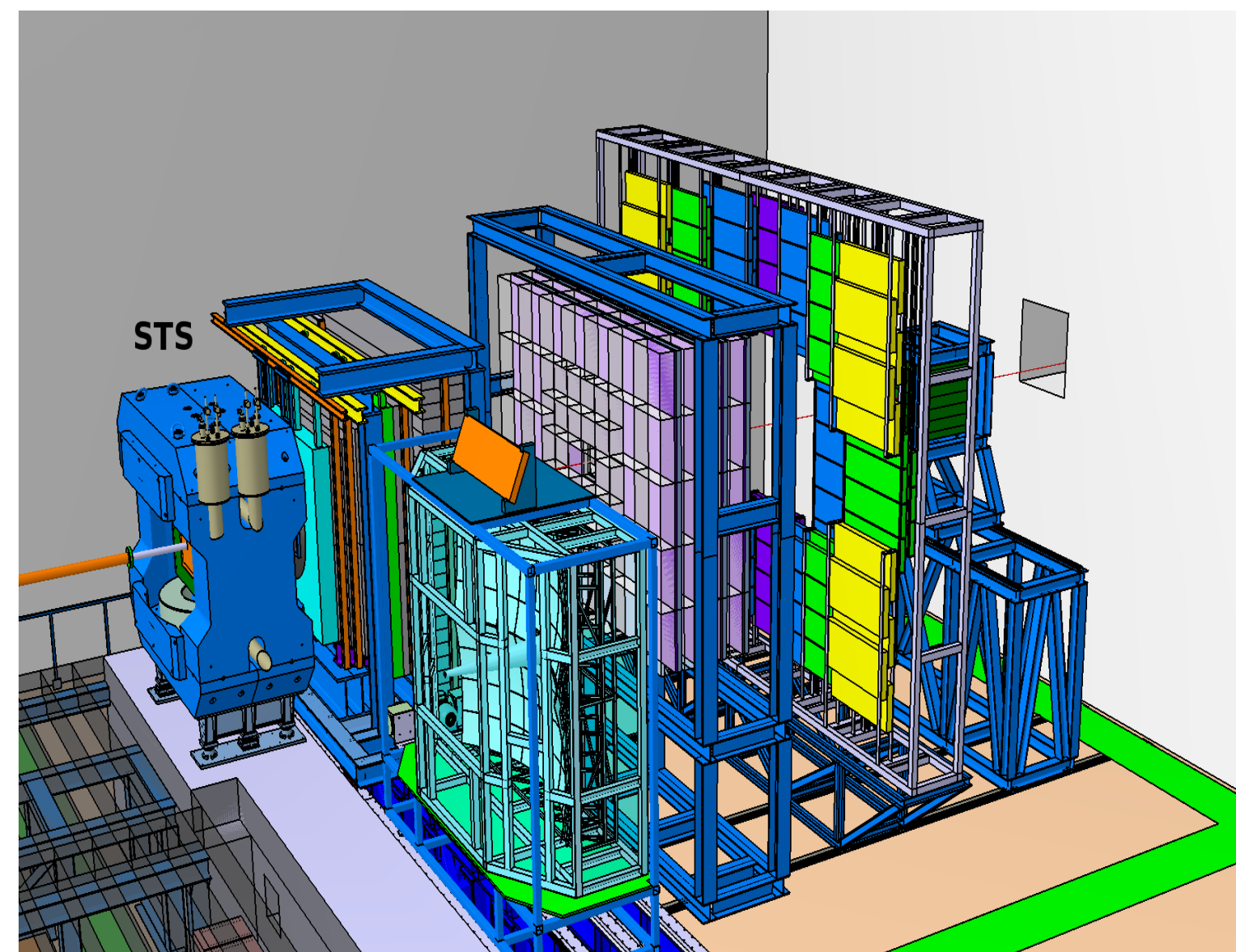
Charge collection study of microstrip sensors for the CBM Silicon Tracking System



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Compressed Baryonic Matter experiment and Silicon Tracking System

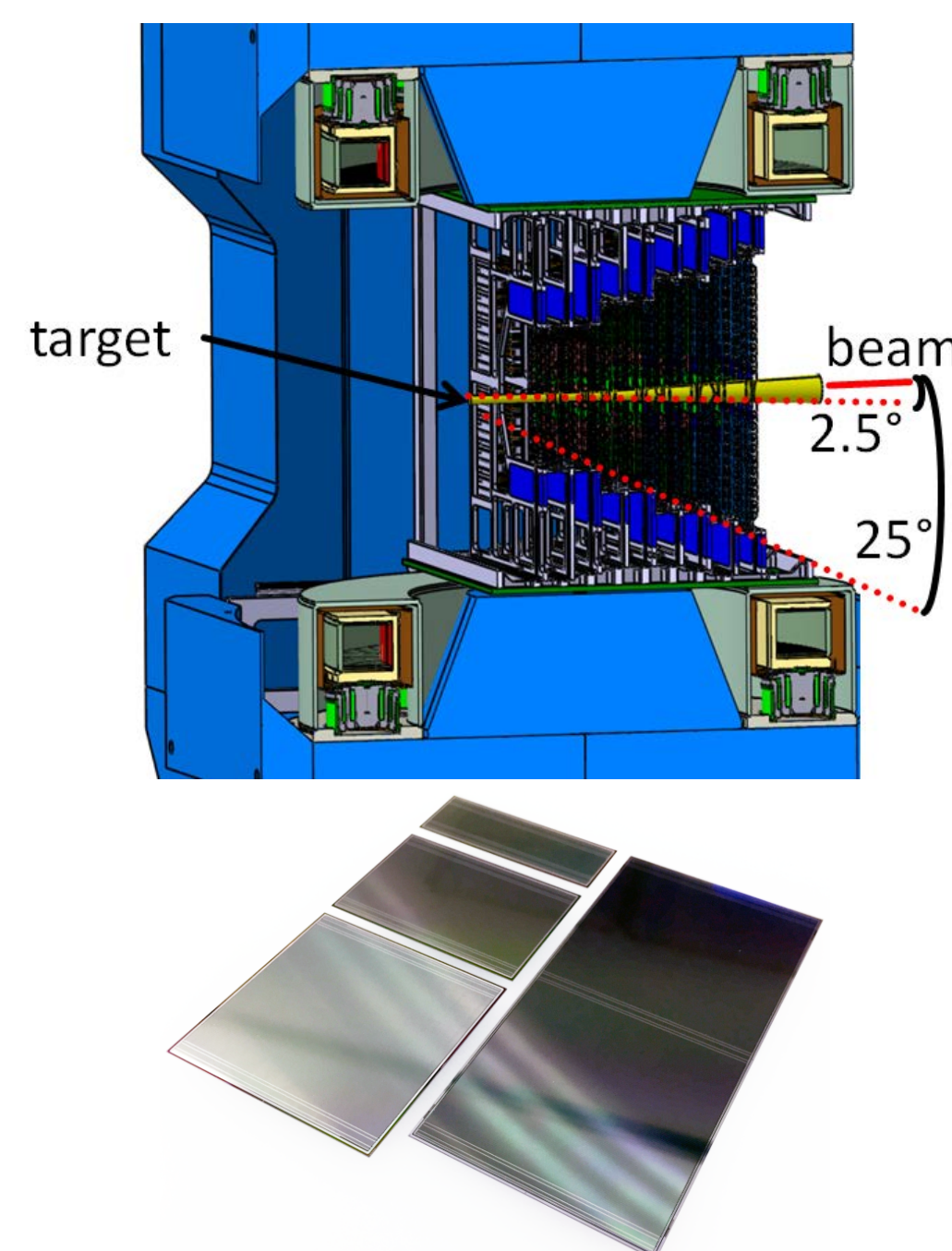


CBM experiment:

- Au+Au collisions @SIS100 2 - 11 AGeV, 10^5 - 10^7 interactions/s;
- up to 10^3 charged particles per central collision.

physics program @SIS100:

- Strangeness;
- Lepton pairs;
- Collective flow, correlations and fluctuations;
- Hypernuclei and hypermatter;
- Charm-anticharm quark pairs.



Silicon Tracking System:

- 8 tracking stations;
- hit rates up to 20 MHz/cm²;
- low material budget $\sim 1\% X_0$;
- 25 μ m hit spatial resolution;
- S/N > 10 for the hit reconstruction efficiency $\sim 98\%$.

Double-sided micro-strip Si sensors:

- 285/320 μ m thick, 58 μ m strip pitch;
- sensor sizes 6x2, 6x4, 6x6, 6x12 cm²;
- 7.5° stereo-angle front-back sides;
- radiation hard: 10^{14} 1 MeV n_{eq} /cm².

Experimental set-up & program of measurement



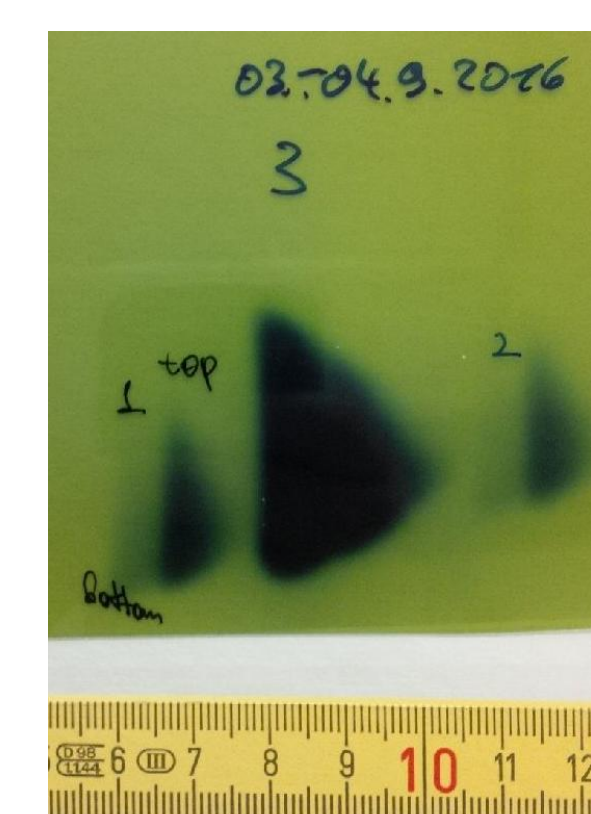
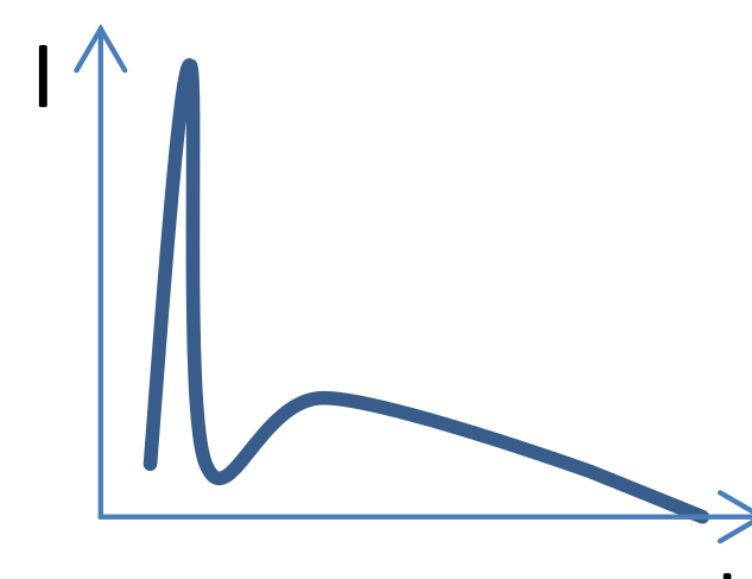
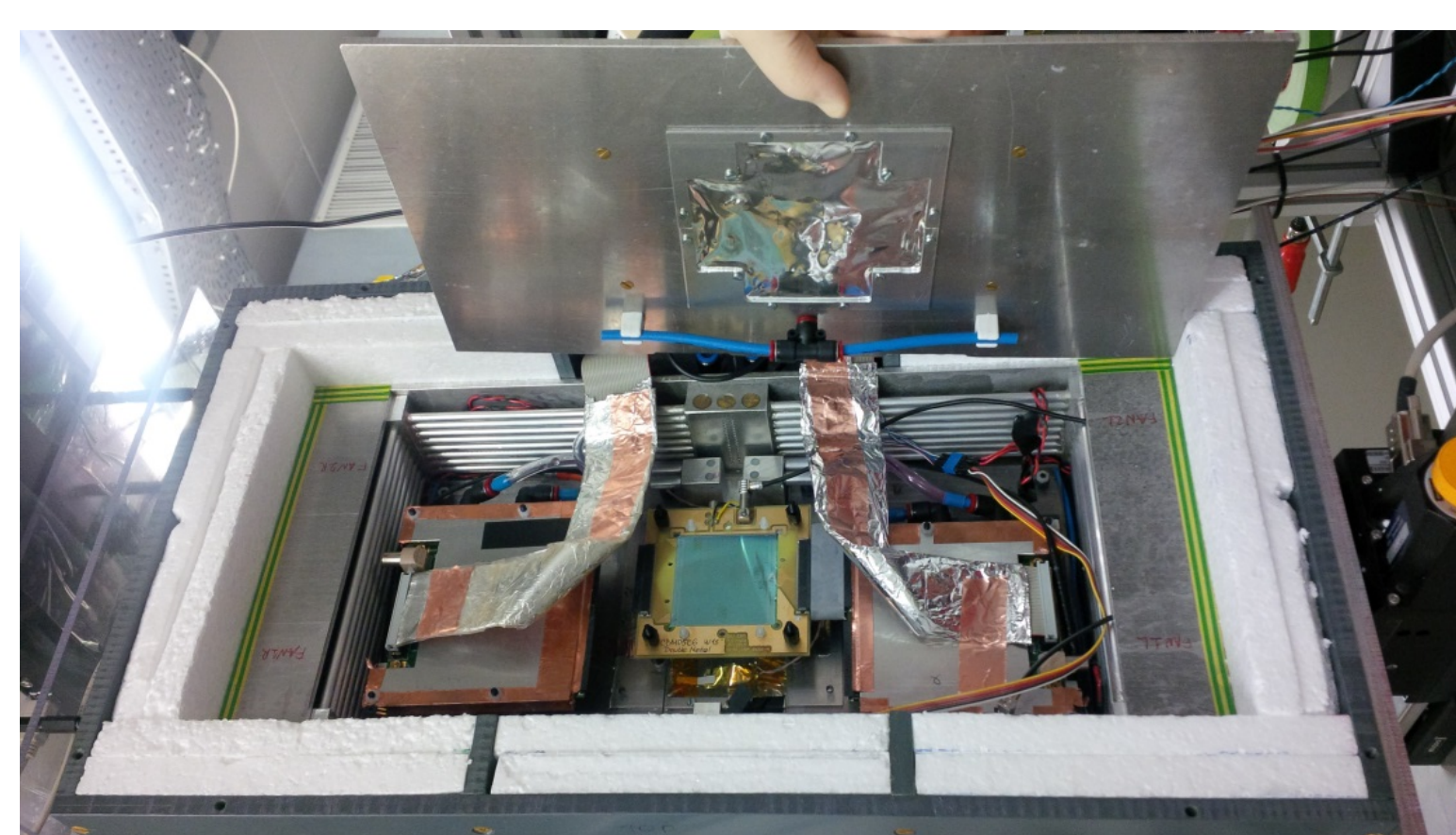
Main components beam test COSY:

- Cold box on movable platform with r/o and exchangeable sensors;
- Warm box with sensor bonded to r/o;

- **Trigger:** two scintillators in coincidence.
- **Read out:** ASIC front-end Beetle and DAQ system (Alibava): -2×128 r/o channels;
 - 40 MHz analog rate;
 - 4 μ s digitization rate.

Proton beam from COSY:

- 1.6 GeV/c $\pm 0.1\%$
- time profile of the beam: spill/inter-spill: 20 s/10 s. sharp spike: 7×10^7 ; bulk extraction: 2×10^8 .



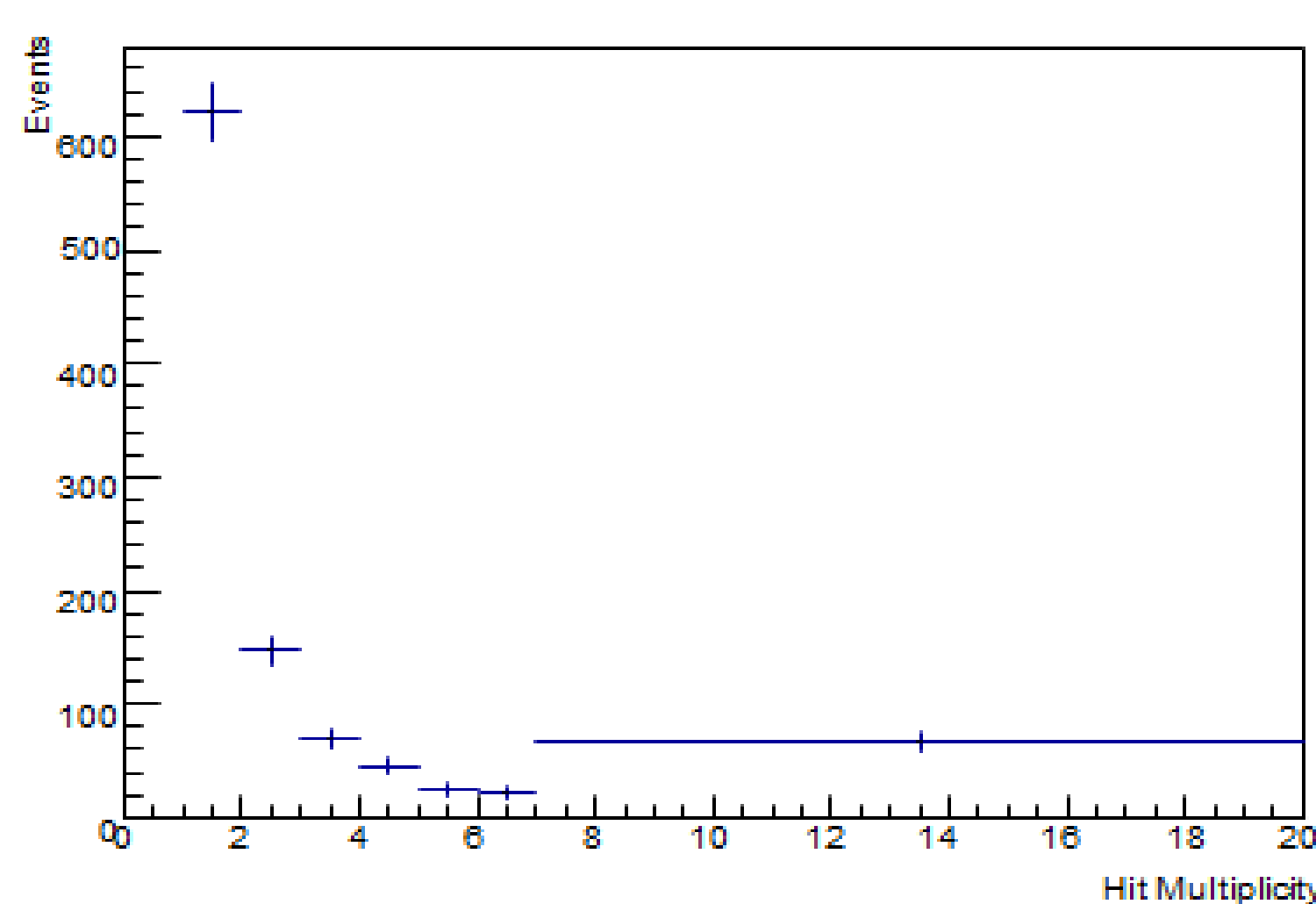
What to measure:

- Charge collection;
- Signal dependence on beam incidence angle;
- Cross talk.

What to compare:

- n-side & p-side performance;
- direct r/o & via metallisation;
- single/double metallisation layout;
- different connection schemes between ASIC and sensor strips.

Event selection

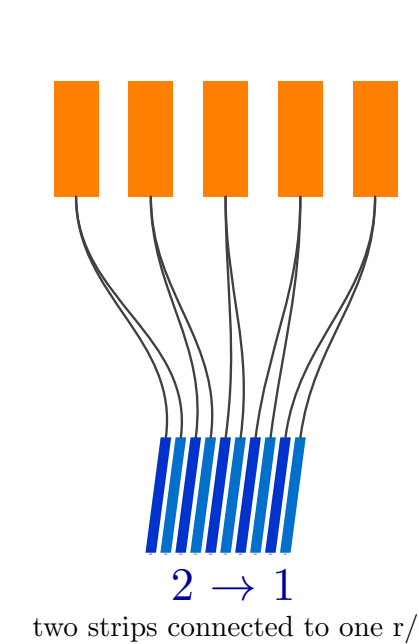
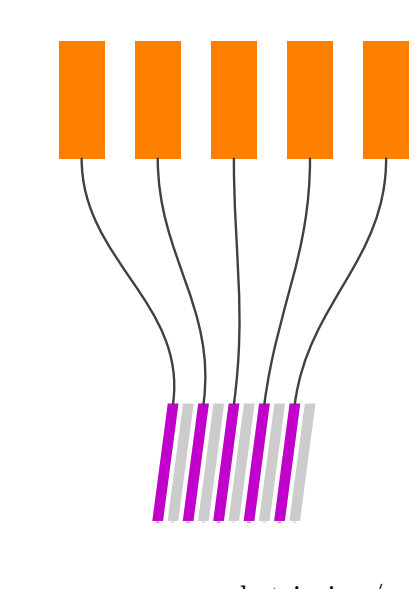
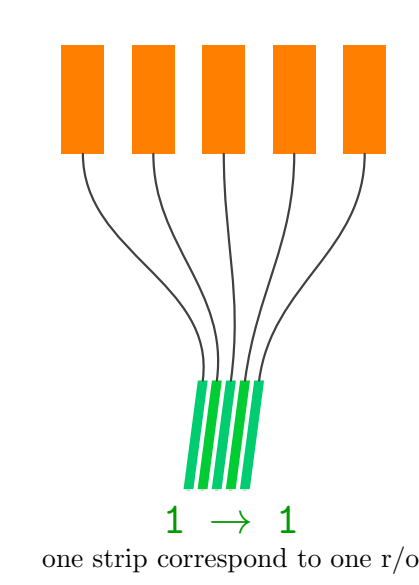


Due to beam micro-spill structure, 50% of data are single hit events.

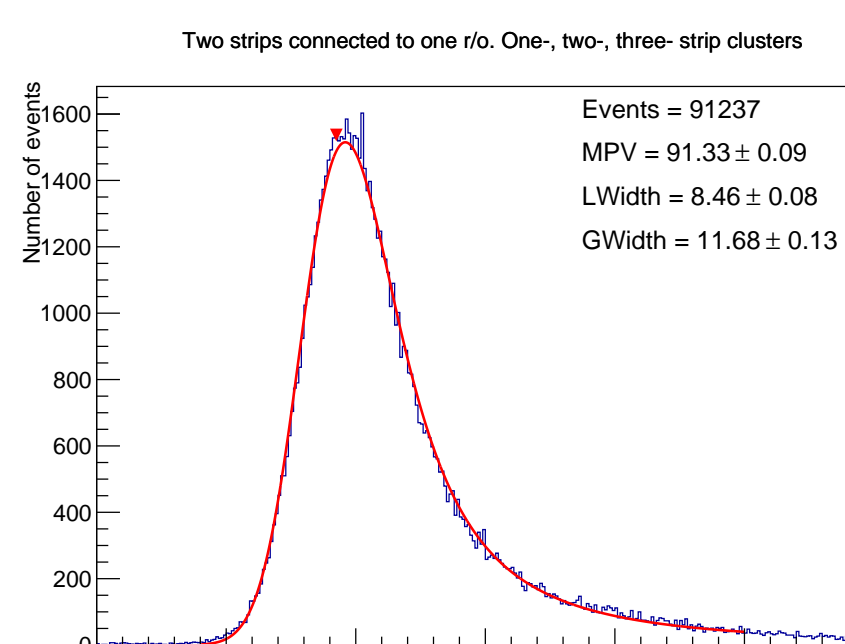
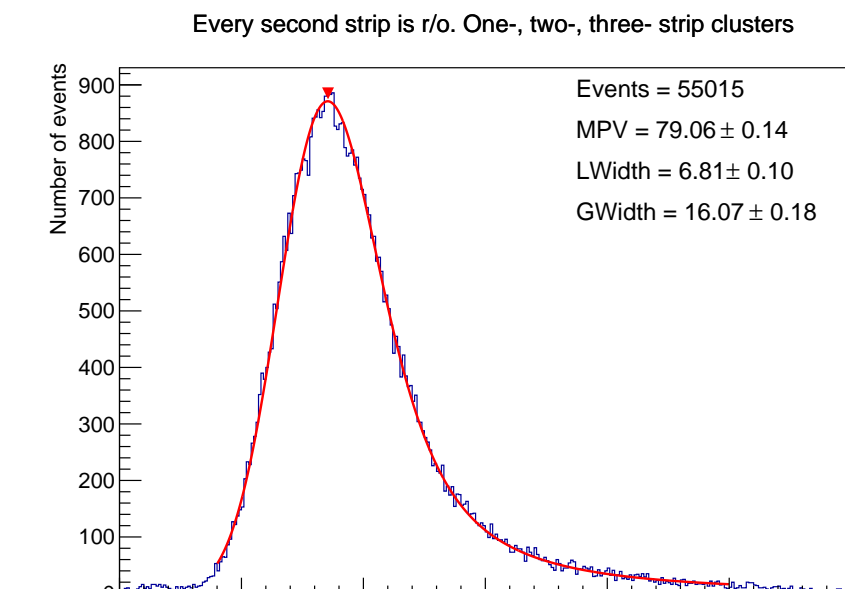
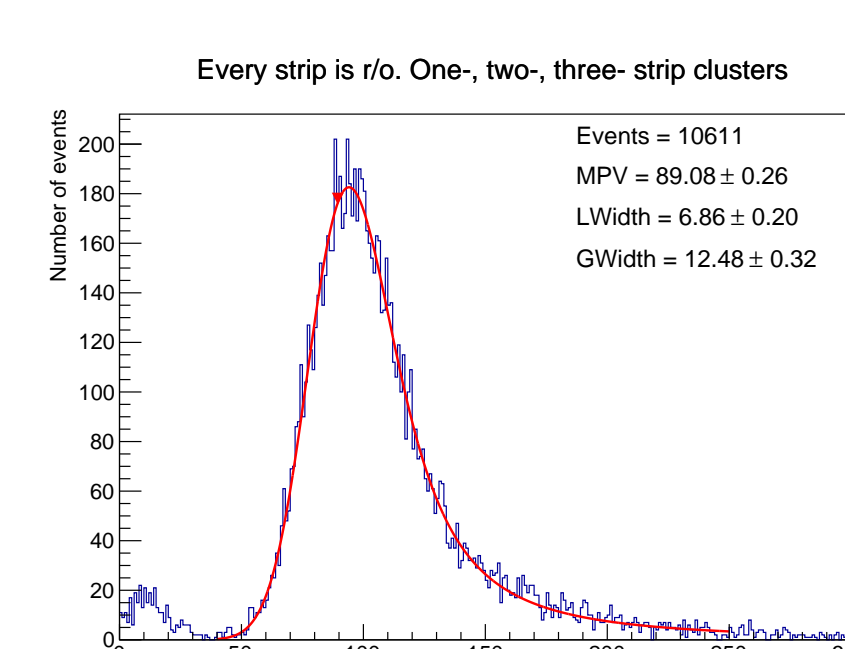
Charge collection at different beam angles

To improve S/N for big cluster sizes, three connection schemes between sensor strips and ASIC channels were tested with beam, incidence angles correspond to the STS acceptance: $0^\circ \leq \Phi \leq 25^\circ$.

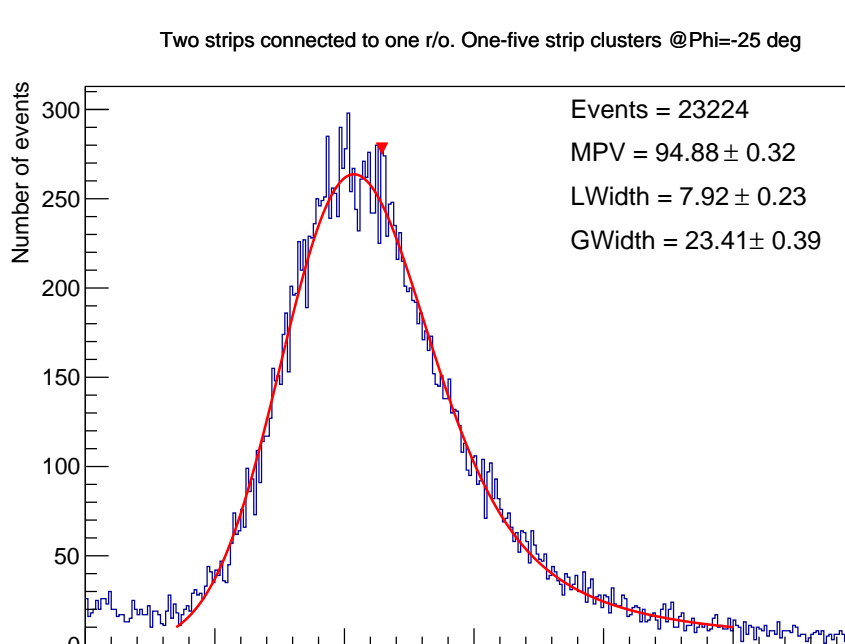
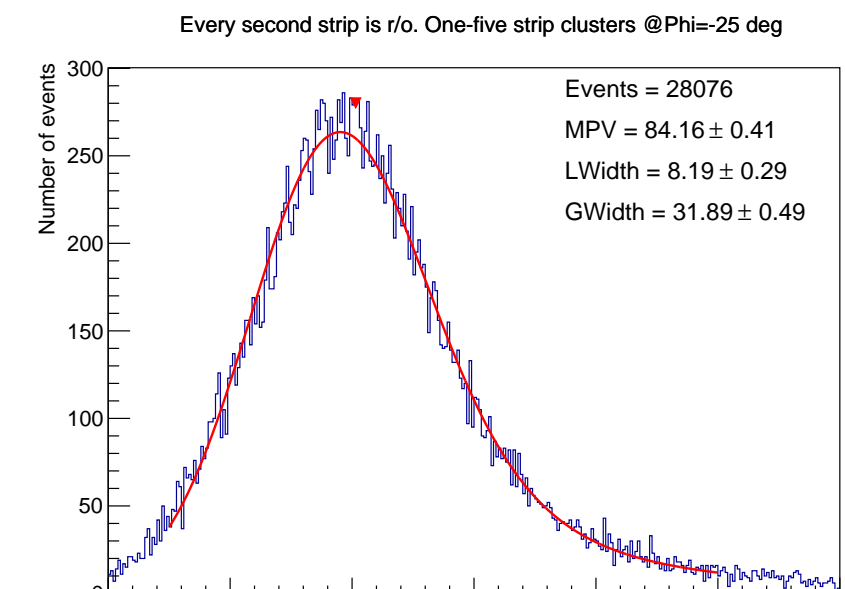
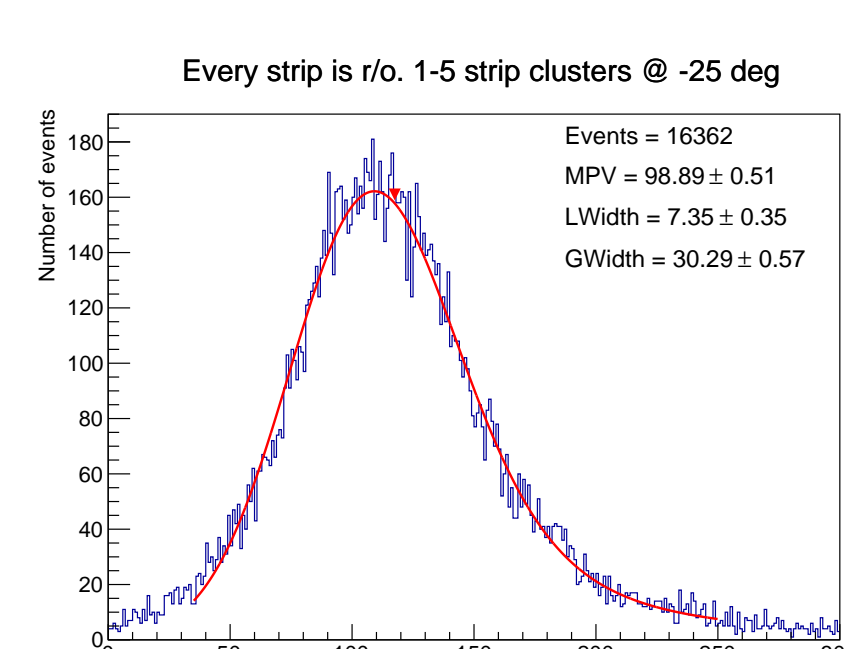
Type of connection



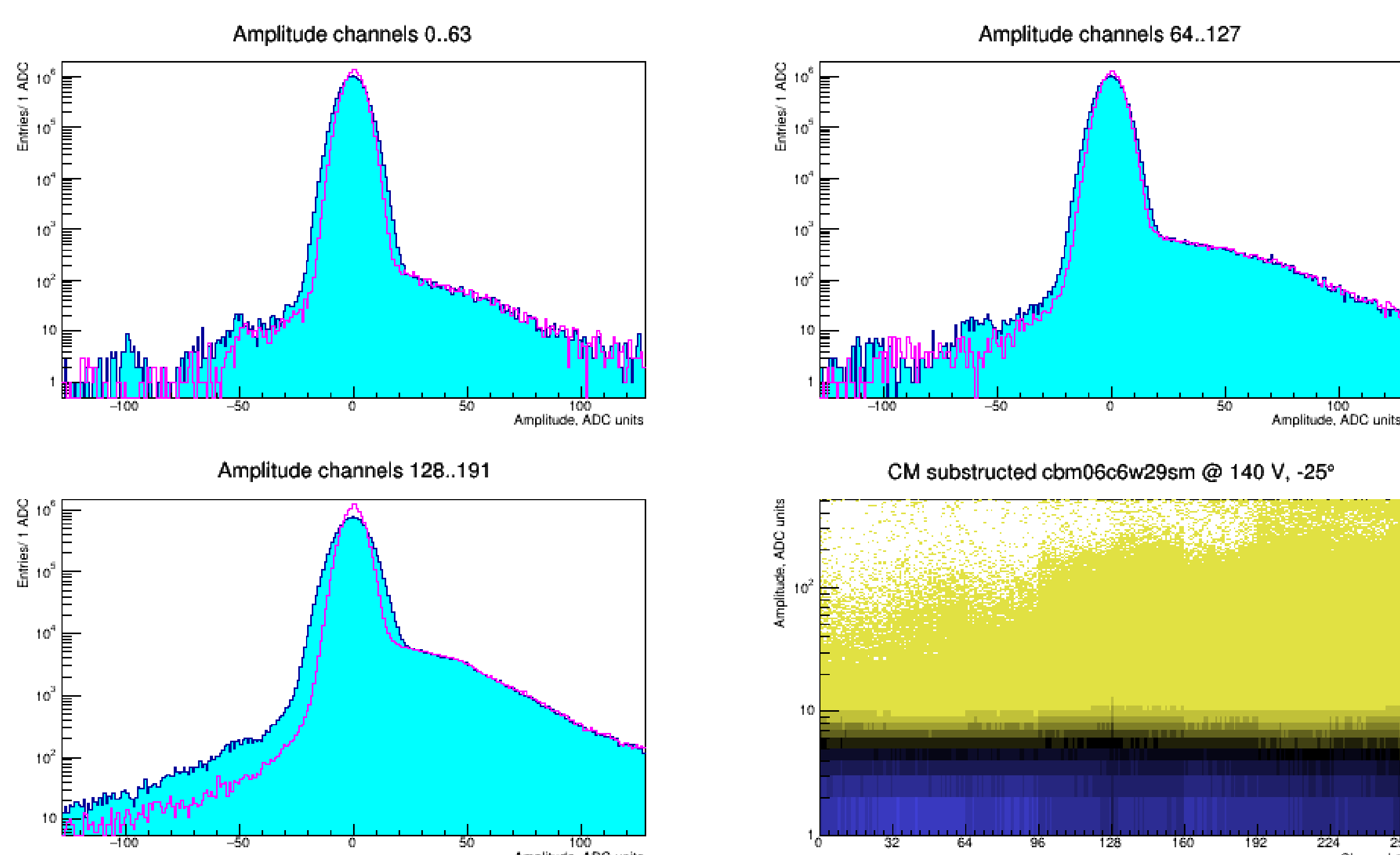
$\Phi = 0^\circ$



$\Phi = 25^\circ$



Common mode correction



Moving baseline was corrected for all 256 channels: blue – before correction, pink – after correction.

Findings

- Cluster size increases with beam incidence angle as expected.
- Noise increases for large cluster sizes (larger capacitive effect).
- Study made in the lab with perpendicular β -particles agree with beam results.
- Connection scheme with every second strip is read out applicable for lateral detector areas.